

HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics U.S.A, Inc.
1000 Sylvan Avenue
Englewood Cliffs, NJ 07632
United States

Date of Testing:

10/29/2018

Test Site/Location:

PCTEST Lab, Columbia, MD, USA

Test Report Serial No.:

1M1810290199-01-R2.ZNF

FCC ID:

ZNFX212TA

APPLICANT:

LG ELECTRONICS U.S.A, INC.

Scope of Test:

RF Emissions Testing

Application Type:

Class II Permissive Change

FCC Rule Part(s):

CFR §20.19(b)

HAC Standard:

ANSI C63.19-2011

285076 D01 HAC Guidance v05

285076 D02 T-Coil testing for CMRS IP v03

DUT Type:

Portable Handset

Model:

LM-X220MA

Additional Model(s):

LMX220MA, X220MA

Test Device Serial No.:

Pre-Production Sample [S/N: 02819]

Class II Permissive Change(s):

See FCC Change Document

Original Grant Date:

03/28/2018

C63.19-2011 HAC Category: M4 (RF EMISSIONS CATEGORY, LTE B26 & B25 Only)

Note: This revised Test Report (S/N: 1M1810290199-01-R2.ZNF) supersedes and replaces the previously issued test report on the same subject device for the same type of testing as indicated. Please discard or destroy the previously issued test report(s) and dispose of it accordingly.

This report and category pertain only to LTE bands 26 & 25 supported by this wireless portable device. The overall category rating of the device is determined by the lowest rating obtained over all air interfaces supported by the device. This wireless portable device has been shown to be hearing-aid compatible for LTE bands 26 & 25, under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested. North America bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.



Randy Ortanez
President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.

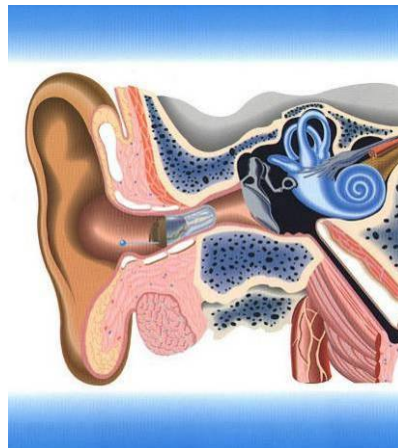


Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. DUT DESCRIPTION



FCC ID: ZNFX212TA
 Manufacturer: LG Electronics U.S.A, Inc.
 1000 Sylvan Avenue
 Englewood Cliffs, NJ 07632
 United States
 Model: LM-X220MA
 Additional Model(s): LMX220MA, X220MA
 Serial Number: 02819
 Antenna Configurations: Internal Antenna
 DUT Type: Portable Handset

Table 2-1
ZNFX212TA HAC Air Interfaces

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service
GSM	850	VO	No ²	Yes: WIFI or BT	CMRS Voice
	1900				
	GPRS/EDGE	VD	No ²	Yes: WIFI or BT	Google Duo
UMTS	850	VD	No ²	Yes: WIFI or BT	CMRS Voice
	1700				
	1900				
	HSPA	VD	No ²	Yes: WIFI or BT	Google Duo
LTE (FDD)	680 (B71)	VD	No ²	Yes: WIFI or BT	VoLTE, Google Duo
	700 (B12)				
	850 (B5)		No ¹		
	850 (B26)				
	1700 (B4)		No ²		
	1700 (B66)				
	1900 (B2)		No ¹		
	1900 (B25)				
WIFI	2450	VD	No ²	Yes: GSM, UMTS, or LTE	VoWIFI, Google Duo
	5200 (U-NII 1)				
	5300 (U-NII 2A)				
	5500 (U-NII 2C)				
	5800 (U-NII 3)				
BT	2450	DT	No	Yes: GSM, UMTS, or LTE	N/A
Type Transport VO = Voice Only DT = Digital Data - Not intended for CMRS Service VD = CMRS and IP Voice over Data Transport			Notes: 1. Evaluated for MIF and low-power exemption. 2. This report only pertains to LTE Band 25 & 26. For full data, please refer to the previous Certification Test Report (RFE Test Report S/N: 1M1802060016-09-R1.ZNF).		

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3. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters
Near field Category	E-field emissions CW dB(V/m)
f < 960 MHz	
M1	50 to 55
M2	45 to 50
M3	40 to 45
M4	< 40
f > 960 MHz	
M1	40 to 45
M2	35 to 40
M3	30 to 35
M4	< 30
Table 3-1 WD near-field categories as defined in ANSI C63.19-2011	

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4. SYSTEM SPECIFICATIONS

ER3DV6 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges
Calibration:	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, $k=2$)
Frequency:	100 MHz to > 6 GHz; Linearity: ± 0.2 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m (M3 or better device readings fall well below diode compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm

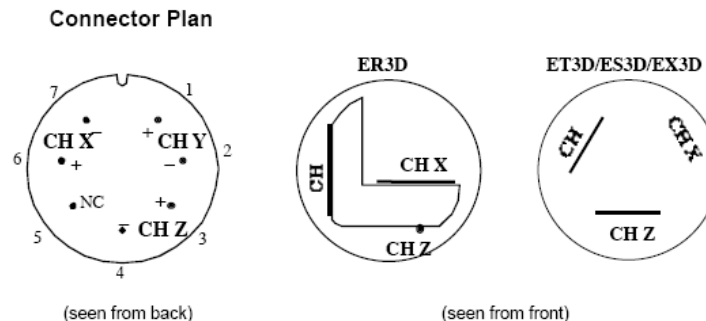


Figure 4-1
E-field Free-space
Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

The electric field probes have an irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement"). Their geometric center is at 2.5mm from the tip, and the element ends are 1.1mm closer to the tip.



The antistatic shielding inside the probe is connected to the probe connector case.

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Instrumentation Chain

Equation 1

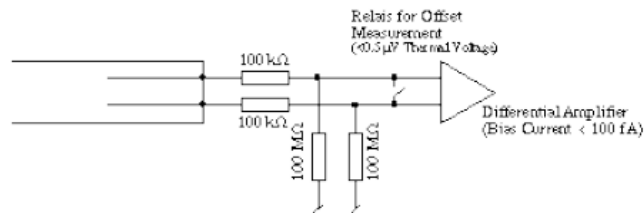
Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

whereby

E_i : electric field in V/m
 u_i : voltage of channel i at the connector in μV
 $Norm_i$: sensitivity of channel i in $\mu V/(V/m)^2$
 $ConvF$: enhancement factor in liquid ($ConvF=1$ for Air)
 DCP : diode compression point in μV
 CF : signal crest factor (peak power/average power)

Conditions of Calibration



Please note:

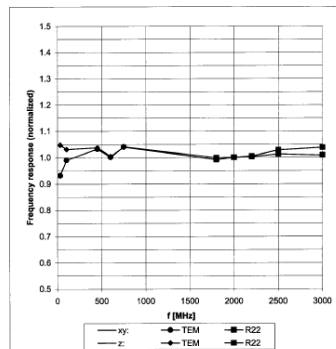
- a lower input impedance of the amplifier will result in different sensitivity factors $Norm_i$ and DCP
- larger bias currents will cause higher offset

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

Frequency Response of E-Field

(TEM-Cell:if110 EXX, Waveguide R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

Figure 4-2 E-Field Probe Frequency Response

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SPEAG Robotic System

E-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Intel CORE i7 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 4-3
SPEAG Robotic System

System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the computer with operating system and RF Measurement Software DASY5 v52.8 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

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System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

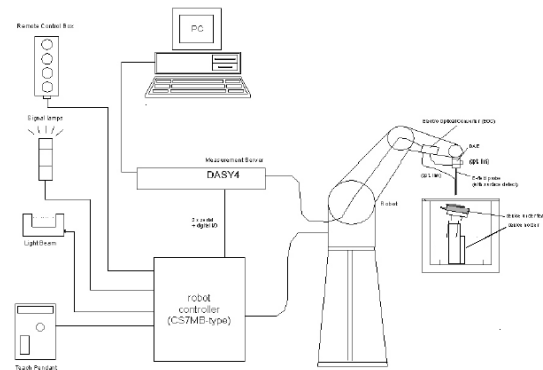


Figure 4-4
SPEAG Robotic System Diagram

DASY5 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

- with
- V_i

U_i

cf

dcp_i

= compensated signal of channel i

= input signal of channel i

= crest factor of exciting field

= diode compression point

$(i = x, y, z)$

$(i = x, y, z)$

(DASY parameter)

(DASY parameter)

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From the compensated input signals the primary field data for each channel can be evaluated:

$$E - \text{fieldprobes : } E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

with V_i = compensated signal of channel i (i = x, y, z)
 $Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
 $\mu V/(V/m)^2$ for E-field Probes
 $ConvF$ = sensitivity enhancement in solution
 E_i = electric field strength of channel i in V/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of <5 ms. In the current implementation, DASY5 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

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5. MODULATION INTERFERENCE FACTOR

I. Measuring Modulation Interference Factors

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be determined that relates its interference potential to its steady-state RMS signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. The MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic; any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field or a conducted RF signal:

- Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- Measure the steady-state RMS level at the output of the fast probe or sensor.
- Measure the steady-state average level at the weighting output.
- Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step c) measurement.
- Without changing the carrier level from step d), remove the 1 kHz modulation and again measure the steady-state RMS level indicated at the output of the fast probe or sensor.
- The MIF for the specific modulation characteristic is provided by the ratio of the step e) measurement to the step b) measurement, expressed in dB ($20 \times \log[(\text{step e})/(\text{step b})]$).

The following procedure was used to measure the MIF using the SPEAG Audio Interference Analyzer (AIA), Type No: SE UMS 170 CB, Serial No.: 1010:

- The device was placed into a simulated call using a base station simulator or set to transmit using test software for a given mode.
- The device was then set to continuously transmit at maximum power.
- Using a coupler if needed, the device output signal was connected to the RF In port of the AIA, which was connected to a desktop computer. Alternatively, a radiated RF signal may be used with the AIA's built-in antenna.
- The MIF measurement procedure in the DASY software was run, and the resulting MIF value was recorded.
- Steps 1-4 were repeated for all CMRS air interfaces, frequency bands, and modulations.

The modulation interference factors obtained were applied to readings taken of the actual wireless device in order to obtain an accurate audio interference level reading using the formula:

$$\text{Audio Interference Level [dB(V/m)]} = 20 * \log[\text{Raw Field Value (V/m)}] + \text{MIF (dB)}$$

Because the MIF value is output power independent, MIF values for a given mode should be constant across all devices; however, per C63.19-2011 §D.7, MIF values should be measured for each device being evaluated. The voice modes for this device have been investigated in this section of the report.

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II. MIF Measurement Block Diagrams

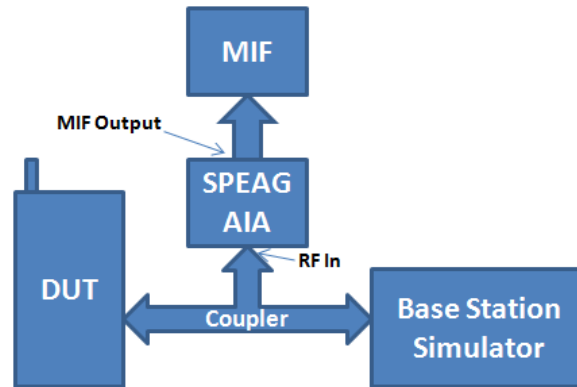


Figure 5-1
MIF Measurement Setup
for licensed modes

III. Measured Modulation Interference Factors:

Table 5-1
LTE FDD Modulation Interference Factors^{1,2}

LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
25	1882.5	26365	20	16QAM	1	0	-10.49
26	831.5	26865	15	16QAM	1	0	-9.99
26	831.5	26865	15	QPSK	1	0	-13.53
26	831.5	26865	15	16QAM	1	36	-10.14
26	831.5	26865	15	16QAM	1	74	-10.16
26	831.5	26865	15	16QAM	36	0	-17.34
26	831.5	26865	15	16QAM	75	0	-19.65
26	831.5	26865	10	16QAM	1	0	-10.01
26	831.5	26865	5	16QAM	1	0	-10.41
26	831.5	26865	3	16QAM	1	0	-10.18
26	831.5	26865	1.4	16QAM	1	0	-9.91
26	814.7	26697	1.4	16QAM	1	0	-10.35
26	848.3	27033	1.4	16QAM	1	0	-10.43

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: All FDD LTE bands were found to have substantially similar MIF values given similar RB, BW, and modulation configurations.

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6. RF CONDUCTED POWER MEASUREMENTS

I. Procedures Used to Establish RF Signal for HAC Testing

The handset was placed into a simulated call using a base station simulator in a shielded chamber. Such test signals offer a consistent means for testing HAC and are recommended for evaluating HAC. Measurements were taken with a fully charged battery. In order to verify that the device was tested and maintained at full power, this was configured with the base station simulator.

II. HAC Measurement Conditions

Output Power Verification

Maximum output power is verified on the High, Middle and Low channels for all applicable air interfaces. See Table 6-1 for air interface specific settings of transmit power parameters.

Table 6-1
Power Control Parameters and Settings by Air Interface

Air Interface:	Parameter Name:	Parameter Set To:
LTE	TPC	"Max Power"

III. Setup Used to Measure RF Conducted Powers

Power measurements for licensed modes were performed using a base station simulator under digital average power.

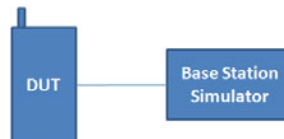


Figure 6-1
Power Measurement Setup for licensed modes

IV. LTE Conducted Powers

a. LTE Band 26

Table 6-2
LTE Band 26 (831.5MHz) Conducted Powers – 15MHz Bandwidth

LTE Band 26 (Cell) 15 MHz Bandwidth					
Modulation	RB Size	RB Offset	Mid Channel 26865 (831.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power [dBm]		
QPSK	1	0	24.11	0	0
	1	36	24.40		0
	1	74	23.95		0
	36	0	23.21		1
	36	18	22.94	0-1	1
	36	37	22.92		1
	75	0	22.92		1
	1	0	22.85		1
16QAM	1	36	22.67	0-1	1
	1	74	22.76		1
	36	0	21.92		2
	36	18	21.97	0-2	2
	36	37	21.96		2
	75	0	21.93		2
	1	0	21.93		2
	1	36	21.93		2

Note: Since LTE Band 26 at 15MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

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Table 6-3
LTE Band 26 (831.5MHz) Conducted Powers – 10MHz Bandwidth

LTE Band 26 (Cell) 10 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26740 (819.0 MHz)	26865 (831.5 MHz)	26990 (844.0 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	24.08	24.15	23.99	0	0
	1	25	24.23	24.23	24.24		0
	1	49	24.19	24.12	24.17		0
	25	0	23.23	23.22	23.24	0-1	1
	25	12	23.10	23.22	23.22		1
	25	25	23.05	23.15	23.22		1
	50	0	23.10	23.15	23.23		1
	50	0	23.10	23.15	23.23		1
16QAM	1	0	23.23	23.02	23.17	0-1	1
	1	25	23.20	23.18	23.22		1
	1	49	23.18	23.01	23.23		1
	25	0	22.14	22.18	22.19	0-2	2
	25	12	22.14	22.20	22.20		2
	25	25	22.17	22.22	22.23		2
	50	0	22.12	22.23	22.11		2
	50	0	22.12	22.23	22.11		2

Table 6-4
LTE Band 26 (831.5MHz) Conducted Powers – 5MHz Bandwidth

LTE Band 26 (Cell) 5 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26715 (816.5 MHz)	26865 (831.5 MHz)	27015 (846.5 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	24.19	23.97	24.26	0	0
	1	12	24.34	24.18	24.38		0
	1	24	24.30	23.97	24.17		0
	12	0	23.34	23.29	23.42	0-1	1
	12	6	23.35	23.38	23.41		1
	12	13	23.25	23.30	23.30		1
	25	0	23.26	23.31	23.41		1
16QAM	1	0	22.96	23.30	23.04	0-1	1
	1	12	22.95	23.06	22.83		1
	1	24	22.98	22.91	22.75		1
	12	0	22.21	22.18	22.33	0-2	2
	12	6	22.22	22.41	22.17		2
	12	13	22.15	22.20	22.41		2
	25	0	22.26	22.17	22.36		2

Table 6-5
LTE Band 26 (831.5MHz) Conducted Powers – 3MHz Bandwidth

LTE Band 26 (Cell) 3 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26705 (815.5 MHz)	26865 (831.5 MHz)	27025 (847.5 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	24.12	24.22	24.09	0	0
	1	7	24.22	24.22	24.15		0
	1	14	24.27	24.06	24.26		0
	8	0	23.27	23.22	23.20	0-1	1
	8	4	23.29	23.23	23.17		1
	8	7	23.27	23.17	23.06		1
	15	0	23.25	23.21	23.15		1
16QAM	1	0	23.20	23.22	22.96	0-1	1
	1	7	22.91	23.27	23.45		1
	1	14	22.82	23.12	23.21		1
	8	0	22.29	22.23	22.21	0-2	2
	8	4	22.27	22.25	22.16		2
	8	7	22.20	22.09	22.23		2
	15	0	22.26	22.20	22.24		2

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Table 6-6
LTE Band 26 (831.5MHz) Conducted Powers – 1.4MHz Bandwidth

LTE Band 26 (Cell) 1.4 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26697 (814.7 MHz)	26865 (831.5 MHz)	27033 (848.3 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	24.22	24.31	24.04	0	0
	1	2	24.26	24.33	24.12		0
	1	5	24.36	23.99	24.04		0
	3	0	24.22	24.21	24.37		0
	3	2	24.26	24.33	24.23		0
	3	3	24.20	24.30	24.27		0
	6	0	23.24	23.30	23.10	0-1	1
16QAM	1	0	23.25	23.21	22.88	0-1	1
	1	2	23.01	23.25	22.87		1
	1	5	23.19	23.02	22.84		1
	3	0	23.46	22.98	22.76		1
	3	2	23.51	23.02	23.33		1
	3	3	23.46	22.98	23.25		1
	6	0	22.35	22.05	22.28	0-2	2

b. LTE Band 25

Table 6-7
LTE Band 25 (1882.5MHz) Conducted Powers – 20MHz Bandwidth

LTE Band 25 (PCS) 20 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26140 (1860.0 MHz)	26365 (1882.5 MHz)	26590 (1905.0 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	23.90	24.07	24.05	0	0
	1	50	23.67	24.17	23.96		0
	1	99	23.90	23.78	24.01		0
	50	0	22.94	22.93	22.73	0-1	1
	50	25	22.89	23.01	22.89		1
	50	50	22.71	22.55	22.53		1
	100	0	22.78	22.80	22.68		1
	16QAM	1	0	22.64	22.40	22.89	0-1
1		50	22.81	22.63	22.71	1	
1		99	22.26	22.35	22.42	1	
50		0	21.92	21.90	21.73	0-2	2
50		25	21.82	21.97	21.90		2
50		50	21.78	21.55	21.60		2
100		0	21.86	21.80	21.68		2

Table 6-8
LTE Band 25 (1882.5MHz) Conducted Powers – 15MHz Bandwidth

LTE Band 25 (PCS) 15 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26115 (1857.5 MHz)	26365 (1882.5 MHz)	26615 (1907.5 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	24.09	23.86	23.86	0	0
	1	36	24.02	24.06	23.98		0
	1	74	24.06	23.99	23.91		0
	36	0	23.10	23.10	22.99	0-1	1
	36	18	23.01	23.08	23.04		1
	36	37	23.09	23.00	22.92		1
	75	0	23.07	23.06	22.91		1
16QAM	1	0	23.02	23.09	23.08	0-1	1
	1	36	23.09	23.09	23.09		1
	1	74	23.10	23.09	23.10		1
	36	0	22.03	22.08	22.09	0-2	2
	36	18	21.96	22.06	22.08		2
	36	37	21.86	21.93	22.09		2
	75	0	21.95	21.96	21.89		2

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Table 6-9
LTE Band 25 (1882.5MHz) Conducted Powers – 10MHz Bandwidth

LTE Band 25 (PCS) 10 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26090 (1855.0 MHz)	26365 (1882.5 MHz)	26640 (1910.0 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	24.17	24.15	24.06	0	0
	1	25	24.18	24.17	24.17		0
	1	49	24.17	24.16	24.14		0
	25	0	23.11	23.17	23.17	0-1	1
	25	12	23.14	23.17	23.16		1
	25	25	23.14	23.05	23.04		1
	50	0	23.18	23.18	23.08		1
16QAM	1	0	23.17	22.57	23.10	0-1	1
	1	25	23.14	23.18	23.17		1
	1	49	23.18	23.10	23.16		1
	25	0	22.09	22.18	22.14	0-2	2
	25	12	22.12	22.18	22.13		2
	25	25	21.97	22.18	22.10		2
	50	0	22.10	22.16	22.17		2

Table 6-10
LTE Band 25 (1882.5MHz) Conducted Powers – 5MHz Bandwidth

LTE Band 25 (PCS) 5 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26065 (1852.5 MHz)	26365 (1882.5 MHz)	26665 (1912.5 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	23.82	23.84	23.95	0	0
	1	12	23.98	23.78	23.99		0
	1	24	23.80	23.66	23.93		0
	12	0	22.93	22.99	22.98	0-1	1
	12	6	22.94	22.99	22.99		1
	12	13	22.96	22.96	22.95		1
	25	0	23.00	22.99	22.99		1
16QAM	1	0	22.81	22.86	22.73	0-1	1
	1	12	22.97	22.56	22.55		1
	1	24	22.87	22.46	22.53		1
	12	0	21.86	22.00	21.99	0-2	2
	12	6	21.99	21.92	21.96		2
	12	13	21.88	21.88	22.00		2
	25	0	21.85	21.91	21.89		2

Table 6-11
LTE Band 25 (1882.5MHz) Conducted Powers – 3MHz Bandwidth

LTE Band 25 (PCS) 3 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26055 (1851.5 MHz)	26365 (1882.5 MHz)	26675 (1913.5 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	23.84	23.94	23.81	0	0
	1	7	23.94	23.94	23.87		0
	1	14	23.99	23.78	23.98		0
	8	0	22.99	22.94	22.92	0-1	1
	8	4	23.01	22.95	22.89		1
	8	7	22.99	22.89	22.78		1
	15	0	22.97	22.93	22.87		1
16QAM	1	0	22.92	22.94	22.68	0-1	1
	1	7	22.63	22.99	23.17		1
	1	14	22.54	22.84	22.93		1
	8	0	22.01	21.95	21.93	0-2	2
	8	4	21.99	21.97	21.88		2
	8	7	21.92	21.81	21.95		2
	15	0	21.98	21.92	21.96		2

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Table 6-12
LTE Band 25 (1882.5MHz) Conducted Powers – 1.4MHz Bandwidth

LTE Band 25 (PCS) 1.4 MHz Bandwidth							
Modulation	RB Size	RB Offset	Low Channel	Mid Channel	High Channel	MPR Allowed per 3GPP [dB]	MPR [dB]
			26047 (1850.7 MHz)	26365 (1882.5 MHz)	26683 (1914.3 MHz)		
			Conducted Power [dBm]				
QPSK	1	0	24.15	24.24	23.97	0	0
	1	2	24.19	24.26	24.05		0
	1	5	24.29	23.92	23.97		0
	3	0	24.15	24.14	24.30		0
	3	2	24.19	24.26	24.16		0
	3	3	24.13	24.23	24.20		0
	6	0	23.17	23.23	23.03		0
16QAM	1	0	23.18	23.14	22.81	0-1	1
	1	2	22.94	23.18	22.80		1
	1	5	23.12	22.95	22.77	0-1	1
	3	0	23.39	22.91	22.69		1
	3	2	23.44	22.95	23.26		1
	3	3	23.39	22.91	23.18		1
	6	0	22.28	21.98	22.21		0-2

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7. JUSTIFICATION OF HELD TO EAR MODES TESTED

I. Analysis of RF Air Interface Technologies

An analysis was performed, following the guidance of §4.3 and §4.4 of the ANSI standard, of the RF air interface technologies being evaluated. The factors that will affect the RF interference potential were evaluated, and the worst-case operating modes were identified and used in the evaluation. A WD's interference potential is a function both of the WD's average near-field field strength and of the signal's audio-frequency amplitude modulation characteristics. Per §4.4, RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so it is possible to exempt them from the product testing specified in Clause 5 of the ANSI standard. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is $\leq 17\text{dBm}$ for all of its operating modes. RF air interface technologies exempted from testing in this manner are automatically assigned an M4 rating to be used in determining the overall rating for the WD.

The worst-case MIF plus the worst-case average antenna input power for all modes are investigated below to determine the testing requirements for this device.

II. Individual Mode Evaluations

Table 7-1
Max Power + MIF calculations for Low Power Exemptions

Air Interface	Maximum Average Power (dBm)	Worst Case MIF (dB)	Total (Power + MIF, dB)	C63.19 Testing Required
LTE - FDD	24.40	-9.91	14.49	No

III. Low-Power Exemption Conclusions

LTE FDD is exempt from RF emissions testing and rated M4 under the low power exemption of Clause 4 of ANSI C63.19-2011.

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8. EQUIPMENT LIST

Table 8-1
Equipment List

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Pasternack	PE2237-20	Bidirectional Coupler	N/A	CBT*	N/A	N/A
Rohde & Schwarz	CMW500	Radio Communication Tester	5/29/2018	Annual	5/29/2019	162125
Seekonk	NC-100	Torque Wrench (8" lb)	5/10/2018	Biennial	5/10/2020	21053
SPEAG	AIA	Audio Interference Analyzer	N/A	CBT*	N/A	1010

Calibration traceable to the National Institute of Standards and Technology (NIST).

***Note: CBT (Calibrated Before Testing).** Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

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9. MEASUREMENT UNCERTAINTY

Table 9-1
Uncertainty Estimation Table

Wireless Communications Device Near-Field Measurement Uncertainty Estimation							
Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Unc. (dB)	Notes/Comments
Measurement System							
RF System Reflections	0.50	Tolerance	N	1.00	1	0.50	* Refl. < -20 dB
Field Probe Calibration	0.21	Tolerance	N	1.00	1	0.21	
Field Probe Isotropy	0.01	Tolerance	N	1.00	1	0.01	
Field Probe Frequency Response	0.135	Tolerance	N	1.00	1	0.14	
Field Probe Linearity	0.013	Tolerance	N	1.00	1	0.01	
Modulation Interference Factor	0.20	Tolerance	R	1.73	1	0.12	Applicable for M-rating testing
Boundary Effects	0.105	Accuracy	R	1.73	1	0.06	*
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.12	*
Probe Positioner	0.050	Accuracy	R	1.73	1	0.03	*
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	0.03	*
Resolution to 2mm error	0.21	Tolerance	N	1.00	1	0.21	
System Detection Limit	0.05	Tolerance	R	1.73	1	0.03	*
Readout Electronics	0.015	Tolerance	N	1.00	1	0.02	*
Integration Time	0.11	Tolerance	R	1.73	1	0.06	*
Response Time	0.033	Tolerance	R	1.73	1	0.02	*
Phantom Thickness	0.10	Tolerance	R	1.73	1	0.06	*
System Repeatability (Field x 2=power)	0.17	Tolerance	N	1.00	1	0.17	*
Test Sample Related							
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	0.12	*
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	0.03	*
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	0.06	*
Power Drift	0.21	Tolerance	R	1.73	1	0.12	
Combined Standard Uncertainty (k=1)						0.66	16.3%
Expanded Uncertainty [95% confidence]						1.31	32.6%
Expanded Uncertainty [95% confidence] on Field						0.66	16.3%

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.
2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

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10. CONCLUSION

The measurements indicate that LTE bands 26 & 25 of the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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